





Parameters of the RICH .

- Čerenkov angle for $\beta = 1$ particle: 52 mrad
- Number of photons per $\beta = 1$ particle: 32
- Figure of merit N_0 : $42cm^{-1}$
- Single photon angular resolution:
 - \rightarrow 16 channel PMT region: (0.7 \oplus 3.5/p) mrad
 - \rightarrow 4 channel PMT region: (1.0 \oplus 3.5/p) mrad
 - \rightarrow including track error: 1.2 mrad (mean) , 0.8 mrad (above 40GeV/c)



Fourth Workshop on RICH Detectors



Experimental environment

- Events every 96 ns
- Several interactions per event
 - \rightarrow on average 200 charged particles enter the RICH
 - \rightarrow on average 80 rings on the photon detector
 - \rightarrow channel occupancies up to 20%
- Only 20 completely reconstructed tracks per event (on average), 15 above Čerenkov threshold
 - \rightarrow for those tracks PID is required
 - \rightarrow 80% of background rings
- \Longrightarrow Extended likelihood method is used for PID







Particle identification: the method

► 6 possible hypotheses for a track:

electron, muon, pion, kaon, proton, ghost

- Measurement: Čerenkov angle θ_i of photon-track pairs
- Extended likelihood probability for k-th hypothesis:

$$\log \mathcal{L}_k = \sum_{i=1}^{N_{ph}} \log(pG(\theta_i) + (1-p)B(\theta_i)) + \log P(N^{exp}, N_{ph})$$

$$G(\theta_i) = \frac{1}{\sqrt{2\pi\sigma_i}} e^{\frac{(\theta_i - \Theta_k)}{2\sigma_i^2}}$$
$$B(\theta_i) = a\theta_i$$
$$p = \frac{N_S}{N^{exp}}$$
$$\frac{N_S}{N^{exp}} = N_S + \frac{N_{Bgr}}{N_{ph}}$$
$$P(\mu, n) = \frac{\mu^n}{n!} e^{-\mu}$$

Gaussian shape of signal (Θ^k , σ_i) normalized linear background signal fraction expected number of signal photons expected number of signal + background photons number of photons within $\theta_i < 70 mrad$ Poisson distribution

• N_{Bgr} estimated by counting photons outside $\pm 3\sigma$ of expected peak positions

Particle identification: the method

Normalized likelihood probability:

$$l_k = \frac{\mathcal{L}_k}{\sum_{i=1}^6 \mathcal{L}_i}, \qquad k = e, \mu, \pi, K, p, ghost$$

 \implies Likelihood probabilities have range of values between 0 and 1.

Particle selection made by applying a cut on the appropriate likelihood

Particle identification: selection criteria

- Soft, medium and hard selection cuts defined
 - pion selection: cut on sum of e, μ , π likelihood probabilities
 - kaon selection: cut on K likelihood probability
 - proton selection: cut on p likelihood probability

selection	soft	medium	hard
pion	0.05	0.50	0.95
kaon	0.05	0.30	0.95
proton	0.05	0.30	0.95









H E R A





Particle Identification with HERA-B RICH (page 12)

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• Momentum dependent cut: keep pion fake probability at a given level

Cut applied on log-likelihood difference:

$$\log \mathcal{L}_k - \log \mathcal{L}_\pi > C_{K\pi}(p) \qquad \log \mathcal{L}_p - \log \mathcal{L}_\pi > C_{p\pi}(p)$$

Efficiency at 5% pion fake





Conclusions _



- Particle identification capabilities of HERA-B RICH have been presented.
- For the particle identification an extended likelihood method is used.
- It has been shown, using the data of run period 2000, that the RICH is capable of efficient particle identification at high track densities and high interaction rates of the HERA-B experiment.